NANOVEA *PB1000*

LARGE PLATFORM MECHANICAL TESTER





ULTIMATE TESTING

All modes of testing with true load control feedback from independent load and depth sensors provide unmatched accuracy and the highest repeatability available on the market.

NANO & MICRO MODULES BOTH ON ONE SYSTEM

100 mm MOTORIZED Z STAGE for a WIDE RANGE OF SAMPLE SIZES

LATERAL ACCURACY of <0.2 μm with PRECISION ENCODER

NON-CONTACT 3D PROFILER, AFM

and VIDEO MICROSCOPE INTEGRATION

NANOVEA

WIDEST RANGE OF TESTING SOLUTIONS

Designed with unique advanced technologies, **NANOVEA** systems provide the highest accuracy and repeatability with the widest range of measurements capabilities.

INDENTATION





HARDNESS & ELASTIC MODULUS

FRACTURE TOUGHNESS



YIELD STRENGTH & FATIGUE



CREEP & RELAXATION



STRESS VS STRAIN



LOSS & STORAGE MODULUS

SCRATCH







COEFFICIENT OF FRICTION

LOAD MODULES AVAILABLE ON PB1000:



HIGH PRECISION CAPACITOR DEPTH SENSOR

DESIGNED TO ELIMINATE INACCURATE SLOW SURFACE REFERENCING

DIRECT VERTICAL LOADING | NO CANTILEVER OR PIVOT POINT

INDEPENDENT DEPTH & LOAD SENSORS FOR THE HIGHEST ACCURACY

Fast Piezoelectric Actuator Optional 1.5 mm depth Accurate DMA & CSM Ultra sensitive Load Cell High-speed Mapping



Powerful Leadscrew Servomotor

Most sensitive AE sensor

Widest usable load range (5 orders of magnitude)

Best sensitivity down to nano load

Optional 400 N

INDENTATION • SCRATCH • WEAR • FRICTION

▼ NANO

MODULES



Indentation, Scratch, Wear & Friction –	MODES OF TESTING	 Indentation, Scratch, Wear & Friction
Piezoelectric Actuator	LOADING SYSTEM	Ball Screw Servomotor
Ultra Precision Load Cell	LOAD SENSOR	Precision Load Cell
80 400 1800 4800 mN	LOAD RANGE	20 40 200 400 N
0.006 0.03 0.14 0.28 μN	LOAD RESOLUTION (24bit)	1.2 2.4 12 24 μΝ
0.5 1 4 12 μΝ	LOAD NOISE FLOOR RMS	50 100 500 1000 μΝ
Capacitor Ring	DEPTH SENSOR	Large Area Capacitor
250 1500 μm	DEPTH RANGE	1 mm (extended range capability)
0.003 nm	DEPTH RESOLUTION (24bit)	0.01 nm
0.04 nm	DEPTH NOISE FLOOR RMS	0.15 nm
Ultra Precision Load Cell	FRICTION SENSOR	Precision Load Cell
50 400 1800 mN	FRICTION RANGE	20 200 N
0.004 0.14 0.28 μN	FRICTION RESOLUTION	1.2 12 μN
0.3 6 12 μΝ	FRICTION NOISE FLOOR RMS	1.2 2 mN
150 - 400 kHz*	ACOUSTIC EMISSION FREQUENCIES	150 - 400 kHz
0.005 aJ	SENSITIVITY OF AE ABSOLUTE ENERGY	0.005 aJ
0.1 to 100 Hz	DMA / CSM FREQUENCIES	N/A
Yes		N/A
5 min (100 indents)	FASTMAP	12 min (100 indents)
275° 450°C	HIGH TEMPERATURE	275° 450° 600°C
Down to -10°C <-40°C	LOW TEMPERATURE	Down to -10°C <-40°C
5% to Dew Point	HUMIDITY	5% to Dew Point
RT to 60°C	LIQUID	RT to 60°C

* Other frequency range available; Nano only available under sample.

Specifications subject to change, please contact us for the latest.

GUIDE TO INDENTER GEOMETRIES



BERKOVICH

INSTRUMENTED INDENTATION: Hardness & Modulus



VICKERS

INSTRUMENTED INDENTATION: Hardness, Modulus & Fracture Toughness



CUBE CORNER

INSTRUMENTED INDENTATION: Hardness, Modulus & Fracture Toughness



KNOOP

INSTRUMENTED INDENTATION: Hardness & Modulus

Anisotropic Material Studies



BALL

INSTRUMENTED INDENTATION: Hardness & Modulus

Soft Materials (e.g. hydrogels). High indentation depth & force testing

INSTRUMENTED SCRATCH & WEAR:

Adhesive & Cohesive Failures, Scratch Resistance, Wear Rate & COF



CONICO-SPHERICAL

INSTRUMENTED INDENTATION: Hardness, Modulus & Stress-Strain

> 60° cone angle Polymers & Metals

INSTRUMENTED SCRATCH:

90° cone angle Low Load Adhesive & Cohesive Coating Failure 120° cone angle High Load Adhesive & Cohesive Coating Failure



CIRCULAR FLAT

INSTRUMENTED INDENTATION: Ultimate Yield Strength (UYS) & Yield Strength (YS)

Metals, Polymers & Small Particles



KNIFE

INSTRUMENTED SCRATCH: Adhesive & Cohesive Failures

Small Diameter Coated Cylinders



HIGH TEMP

Temperatures up to 600°C.

Enclosed testing chamber for homogenous and accurate temperature control.

Designed with MACOR material (thermal expansion coefficient < 10⁶/°C).

LOW TEMP

Temperatures lower than -40°C.

Enclosed testing chamber for homogenous and accurate temperature control.

Peltier cooling system for optimal accuracy.

ENVIRONMENTAL MODULES



HUMIDITY

Humidity control below 5% & up to environmental dew point.

Enclosed testing chamber for homogenous and accurate temperature control.

LIQUID

Liquid heating up to 60°C.

Custom liquid cup designs for every application need.



X-Y	Ζ	• • •	X-Y
MOTORIZED	MOTORIZED	•	LATERAL
STAGES	APPROACH	• •	RESOLUTION
200 X 150 mm	100 mm	• • •	0.1 μm

SUPERIORITY OF COMPRESSIVE LOAD CELL



THE BETTER INDENTATION ACCURACY



THE BETTER SCRATCH & WEAR



FLAWS OF SURFACE REFERENCING TECHNOLOGY



MICROSCOPE VIDEO IMAGING

up to 100x objective magnification

1200 x 1600 color video camera

ACCURACY OF <0.2 μm to/from indenter position

FLAWLESS STITCHING and focus stacking



ATOMIC FORCE MICROSCOPE

AFM expands 3D capabilities into sub-nanometer range down to a single angstrom, including laterally, which is not attainable with any optical technique.

1.7 nm lateral resolution

0.4 nm | 0.13 nm height resolution

STATIC, DYNAMIC & EXTENDED modes

> VIDEO CAMERA integrated



110 um X-Y scan **25 um** high resolution X-Y

22 μm | 5 μm max Z range

ACCURACY of <0.2 μm to/from indenter position or video imaging

3D OPTICAL PROFILER

By measuring the direct physical wavelength linked to a specific height, NANOVEA Optical Profilers provide unmatched accuracy of surface measurements on any material.

No complex algorithms. No sample leveling. No wasted time.

up to 3 mm max Z range

2D & 3D NON-CONTACT surface measurements

ACCURACY OF <0.2 μm to/from indenter position or video imaging

ANY ROUGHNESS, ANY MATERIAL

down to 10 nm accuracy on any form



NANOVEA **PB1000**

THE LARGE PLATFORM MECHANICAL TESTER

For pricing information, please contact SALES@NANOVEA.COM

ALSO AVAILABLE:

NANOVEA CB500 The Advanced Compact Mechanical Tester

NANOVEA.COM